

Notice of References Cited	Application/Control No. 10/811,510		Applicant(s)/Patent Under Reexamination O'ROURKE ET AL.	
	Examiner Tae H. Yoon		Art Unit 1714	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,122,592	10-2006	Wentworth et al.	524/284
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	J	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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